

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10565274	OKUDA ET AL.
	Examiner	Art Unit
	Nguyen, Khiem D	2823

SEARCHED

Class	Subclass	Date	Examiner
257	40, 57, 59, 79	6/19/2007	K.N.
428	690, 917	6/19/2007	K.N.
257	40, E51.022	9/28/2009	/KN/
313	504, 506	9/28/2009	/KN/
428	690, 917	9/28/2009	/KN/

SEARCH NOTES

Search Notes	Date	Examiner
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	6/19/2007	K.N.
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	2/7/2008	K.N.
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	2/5/2009	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	9/27/2009	/KN/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Claims interference searched (US-PGPUB; USPAT), see attached search history.	9/28/2009	/KN/

/	/KHIEM D NGUYEN/ Primary Examiner. Art Unit 2823
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